19-3986; Rev 0; 10/91

Complete, 12-Bit Multiplying DAC

_General Description

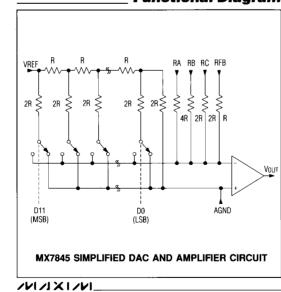
The MX7845 is a 12-bit, voltage-output, 4-quadrant, multiplying digital-to-analog converter (DAC). A precision internal output amplifier and thin-film resistors, laser-trimmed at the wafer level, maintain accuracy over the full operating temperature range. The output amplifier is internally compensated and drives $\pm 10V$ into a $2k\Omega$ load.

The MX7845 has buffered latches that are easily interfaced with microprocessors. Data is transferred into the input register from a 12-bit-wide data path. The input registers are controlled by standard CHIP SELECT (CS) and WRITE (WR) signals. For stand-alone operation, the CS and WR inputs are grounded, making all latches transparent. All logic inputs are level-triggered and compatible with TTL and +5V CMOS logic levels. For a detailed description of MX7845 operation, refer to the MAX501/MAX502 data sheet.

Applications

- Automatic Test Equipment Digital Attenuators
- Programmable Power Supplies
- Programmable-Gain Amplifiers
- Digital to 4-20mA Converters

Functional Diagram



_____ Features

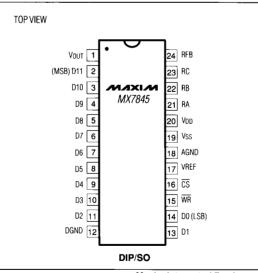
- ♦ Complete MDAC with Output Amplifier
- 4-Quadrant Multiplication
- ♦ Guaranteed Monotonic (T_{MIN} to T_{MAX})
- Matched Application Resistors
- Small 0.3" 24-Pin DIP Package

Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
MX7845JN	0°C to +70°C	24 Narrow Plastic DIP
MX7845KN	0°C to +70°C	24 Narrow Plastic DIP
MX7845JR	0°C to +70°C	24 Wide SO
MX7845KR	0°C to +70°C	24 Wide SO
MX7845JP	0°C to +70°C	28 PLCC
MX7845KP	0°C to +70°C	28 PLCC
MX7845J/D	0°C to +70°C	Dice*
MX7845AEWG	-40°C to +85°C	24 Wide SO
MX7845BEWG	-40°C to +85°C	24 Wide SO
MX7845AQ	-40°C to +85°C	24 Narrow CERDIP
MX7845BQ	-40°C to +85°C	24 Narrow CERDIP
MX7845SE	-55°C to +125°C	28 LCC**
MX7845SQ	-55°C to +125°C	24 Narrow CERDIP**
MX7845TQ	-55°C to +125°C	24 Narrow CERDIP**

Contact factory for dice specifications.
 ** Contact factory for availability and processing to MIL-STD-883.





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MX7845

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MX7845 ABSOLUTE MAXIMUM RATINGS

V _{DD} to DGND	D
Vss to DGND	C
VREF to AGND	t
VRFB to AGND ±25V	
VRA to AGND	0
VBB to AGND ±25V	
VBC to AGND	
VOUT to AGND (Note 1) VDD + 0.3V, VSS - 0.3V	
V _{DD} to AGND	St

V _{DD} to DGND	Digital Input Voltage to DGND
V _{SS} to DGND	Continous Power Dissipation (any package)
VREF to AGND	to +75°C 650mW
VRFB to AGND ±25V	derate above +75°C
V _{RA} to AGND	Operating Temperature Ranges:
V _{RB} to AGND ±25V	MX7845J_/K
V _{RC} to AGND	MX7845A_/B
VOUT to AGND (Note 1) VDD + 0.3V, VSS - 0.3V	MX7845S_/T
V _{DD} to AGND	Storage Temperature Range
AGND to DGND	Lead Temperature (soldering, 10 sec) +300°C

Note 1: VOUT may be shorted to AGND, VDD, or VSS if the package power dissipation is not exceeded.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

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 $(V_{DD} = +15V \pm 5\%, V_{SS} = -15V \pm 5\%, V_{REF} = +10V, AGND = DGND = 0V, V_{OUT}$ connected to RFB, R_L = 2k Ω , C_L = 100pF, T_A = T_{MIN} to T_{MAX}, all grades, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS			TYP	MAX	UNITS	
ACCURACY								
Resolution	N			12			Bits	
		$T_A = +25^{\circ}C$	MX7845K/B/T			±1/2		
		1A = +25 C	MX7845J/A/S			±1		
Relative Accuracy (Note 2)	INT		MX7845K			±3/4	LSB	
			MX7845J/B/T			±1		
			MX7845A			±3/2		
			MX7845S			±2		
Differential Nonlinearity	DNL					±1	LSB	
		T _A = +25°C	MX7845K/B/T			±1		
		IA = +20 C	MX7845J/A/S			±2	mV	
Zero-Code Offset Error (Note 3)			MX7845K/B			±3		
			MX7845J/A/T			±4		
			MX7845S			±5		
Offset Temperature Coefficient	ΔVOS/ ΔTemp				±5		µV/°C	
		RFB, VOUT	MX7845K/B/T			±3		
		connected	MX7845J/A/S			±6	LSB	
Gain Error		RC or RB, V _{OUT} con- nected; VREF = 5V	MX7845K/B/T			±6		
		nected; VREF = 5V	MX7845J/A/S			±9	200	
1		RA, VOUT	MX7845K/B/T			±8	1	
		connected; VREF = 2.5V	MX7845J/A/S			±10		
Gain Temperature Coefficient	∆Gain/ ∆Temp	RFB, VOUT connected			±2		ppm c FSR/°(
Reference Input Resistance				8	12	16	kΩ	
Application Resistor Ratio Matching		RA to RB to RC matchin				0.5	%	

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ELECTRICAL CHARACTERISTICS (continued) ($V_{DD} = +15V \pm 5\%$, $V_{SS} = -15V \pm 5\%$, $V_{REF} = +10V$, AGND = DGND = 0V, V_{OUT} connected to RFB, $R_L = 2k\Omega$, $C_L = 100pF$, $T_A = T_{MIN}$ to T_{MAX} , all grades, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS	
DIGITAL INPUTS							
Input Current	lin	VIN = 0V and VDD			±1	μA	
Input Low Voltage	VIL				0.8	V	
Input High Voltage	VIH		2.4			V	
Input Capacitance	CIN			5		pF	
POWER REQUIREMENTS							
	VDD		14.25		15.75	V	
Supply Voltage (Note 4)	VSS		-14.25		-15.75	v	
Supply Current	IDD	VOUT unloaded			10	- mA	
Supply Current	ISS	Vout unloaded			4		
Development Delection	PSR	V _{DD} only, VREF = -10V			±0.2	%/%	
Power-Supply Rejection	Fan	V _{SS} only			±0.2	/6/ /0	

 Note 2:
 Guaranteed monotonic over temperature.

 Note 3:
 DAC register loaded with all 0s.

 Note 4:
 The MX7845 can operate from ±12V supplies.

TIMING CHARACTERISTICS

(VDD = +15V æ5%, VSS = -15V æ5%, VREF = +10V, AGND = DGND = 0V, TA = TMIN to TMAX, all grades, unless otherwise noted.) (Note 5)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
		$T_A = +25^{\circ}C$	100			
Chip Select to Write-Setup Time	tcs	MX7845J/K/A/B	135			ns
		MX7845S/T	140			
		T _A = +25°C	0			
Chip Select to Write-Hold Time	tсн	MX7845J/K/A/B	0			ns
		MX7845S/T	0			
	twn	T _A = +25°C	100			
Write Pulse Width		MX7845J/K/A/B	135			ns
		MX7845S/T	140			
	tDS	T _A = +25°C	100			
Data-Setup Time		MX7845J/K/A/B	100			ns
	1	MX7845S/T	120	-		
Data-Hold Time	tou	$T_A = +25^{\circ}C$	20			- ns
	tDH		20			

Note 5: All input signal rise and fall times measured from 10% to 90% of +5V; tr \approx tf = 20ns. Timing measurement reference is (VIH + VIL)/2.

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AC PERFORMANCE CHARACTERISTICS

(TA = T_{MIN} to T_{MAX}, all grades, unless otherwise noted.) (Note 6)



PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
DYNAMIC PERFORMANCE							
Output-Voltage Settling Time (Note 7)	ts	VOUT LOAD = 2k	Ω, 100pF		2.5	5.0	μs
Slew Rate	SR	VOUT LOAD = 2ks	Ω, 100pF		7		V/µs
DAC Glitch Impulse (Note 8)					450		(nV)(s)
Multiplying Feedthrough Error (Note 9)					5		mV _{p-p}
Unity-Gain Small-Signal Bandwidth (Note 10)		VOUT, RFB conne	cted		600		kHz
Full-Power Bandwidth (Note 11)		VOUT, RFB conne	cted, $R_L = 2k\Omega$		250		kHz
Total Harmonic Distortion (Note 12)	THD				-90		dB
OUTPUT CHARACTERISTICS (Note 13)							
Open-Loop Gain	Avo	$V_{OUT} = \pm 10V, R_L$	= 2kΩ	85			dB
Output Voltage Swing	Vo	$R_L = 2k\Omega, C_L = 1$	00pF	±10			V
Output Resistance	Ro	RFB, VOUT conne	cted		0.2		Ω
Short-Circuit Current		VOUT, AGND con	nected; $T_A = +25^{\circ}C$		15		mA
			0.1Hz to 10Hz		2		µVRMS
			f = 10Hz		250		
Output Noise Voltage (Note 14)		$T_A = +25^{\circ}C$ $f = 100Hz$		100			
			f = 1kHz		50		nV√Hz
			f = 10kHz		50		
			f = 100kHz		50		

Note 6: AC PERFORMANCE CHARACTERISTICS are included for design guidance and are not subject to test. Note 7: Settling to 0.01% of full-scale range. DAC register alternately loaded with all 0s and all 1s. Note 8: Measured with VREF = 0V. DAC register alternately loaded with all 0s and all 0s. Note 9: VREF = $\pm 10V$, 10kHz sine wave. DAC register loaded with all 0s. Note 10: DAC register loaded with all 1s. VREF = $100mV_{P-P}$ sine wave. Note 11: DAC register loaded with all 1s. VREF = $20V_{P-P}$ sine wave. Note 12: VREF = $6V_{RMS}$, 1kHz sine wave. Note 13: $2k\Omega$ minimum specified load resistance. Note 14: Includes output amplifier noise and Johnson Noise of RFB.

Pin Description

DIP/SO	PLCC/ LCC	NAME	FUNCTION	DIP/SO	PLCC/ LCC	NAME	FUNCTION	
PIN	PIN	1	PIN	PIN				
1	2	VOUT	Voltage Output	19	23	VSS	-12V to -15V Supply Voltage Input	
2-11	3-7, 9-13	D11-D2	Data Bits 2 to 11 (MSB)					
12	14	DGND	Digital Ground	20	24	VDD	+12V to +15V Supply Voltage	
13, 14	16, 17	D1, D0	Data Bits 0 to 1 (LSB)	21	25	RA	Scaling Resistor: RA = 4RFB	
15		WR	Write Input. Active Low.	22	26	RB	Scaling Resistor: RB = 2RFB	
16	19	CS	Chip-Select Input. Active Low.	23	27	RC	Scaling Resistor: RC = 2RFB	
17	20	VREF	Reference Input to DAC	24	28	RFB	Feedback Resistor	
18	21	ÁGND	Analog Ground		1, 8, 15, 22	N.C.	No Connect	

For application information, refer to the MAX501/MAX502 data sheet.

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